

## JianYan Testing Group Shenzhen Co., Ltd.

Report No.:

# **TEST REPORT**

Applicant: Nebra Ltd

**Address of Applicant:** Unit 4 Bells Yew Green Business Court, Bells Yew Green,

Tunbridge Wells TN3 9BJ

**Equipment Under Test (EUT)** 

Product Name: Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot

Miner

Model No.: HNTIN-470-G, HNTIN-868-G, HNTIN-915-G, HNTIN-433-G,

HNTIN-470, HNTIN-868, HNTIN-915, HNTIN-433

**Applicable standards:** EN 55032:2015

EN 55035:2017

EN 61000-3-2:2014, EN 61000-3-3:2013

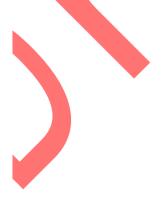
Date of sample receipt: 12 Mar., 2021

**Date of Test:** 13 Mar., to 19 Apr., 2021

Date of report issue: 23 Apr., 2021

Test Result: PASS\*

\* In the configuration tested, the EUT complied with the standards specified above.



The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EC Directives. The protection requirements with respect to electromagnetic compatibility contained in Directive2014/30/EU are considered.

#### Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the JYT product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

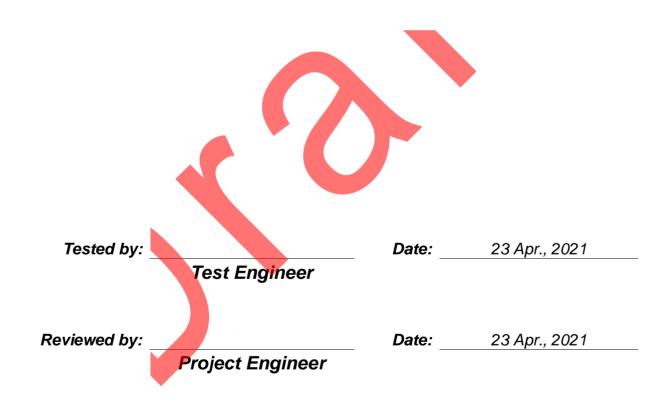
This report may only be reproduced and distributed in full. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards.

This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only.



## 2 Version

Version No.	Date	Description
00	23 Apr., 2021	Original





## 3 Contents

		Page
1	1 COVER PAGE	1
2	2 VERSION	2
3		
4		
5	5 GENERAL INFORMATION	5
	5.1 CLIENT INFORMATION	5
	5.2 GENERAL DESCRIPTION OF E.U.T	
	5.3 TEST MODE AND VOLTAGE AND TEST SAMPLES PLANS	
	5.4 DESCRIPTION OF SUPPORT UNITS	
	5.5 MEASUREMENT UNCERTAINTY	
	5.6 DESCRIPTION OF CABLE USED	
	5.7 LABORATORY FACILITY	
	5.9 MONITORING OF EUT FOR THE IMMUNITY TEST	
	5.10 Test Instruments List	
6		
	6.1 EMI (EMISSION)	10
	6.1.1 Radiated Emission	
	6.1.2 Conducted Emission	
	6.1.3 Harmonics Test Result	
	6.1.4 Flicker Test Result	19
	6.2 EMS (IMMUNITY)	20
	6.2.1 Performance Criteria Description in EN 55035	20
	6.2.2 Electrostatic Discharge	21
	6.2.3 Continuous RF electromagnetic radiated field distu	
	6.2.4 Electrical Fast Transients	
	6.2.5 Surge	
	6.2.6 Continuous induced RF disturbances	
	6.2.7 Power frequency magnetic field	
	6.2.8 Voltage Dips and Voltage Interruptions	34
7	7 TEST SETUP PHOTO	35
R	R FUT CONSTRUCTIONAL DETAILS	Δ1



## 4 Test Summary

Test Requirement	Test Method	Class / Coverity	D
	rest wethou	Class / Severity	Result
EN 55032	EN 55032	Class B	PASS
EN 55032	EN 55032	Class B	PASS
EN 61000-3-2	EN 61000-3-2	N 61000-3-2 N/A	
EN61000-3-3	EN61000-3-3	EN 61000-3-3	
EN 55035	EN61000-4-2:2009	Contact +4 Ky	
EN 55035	EN61000-4-3: 2006+A1:2007+A2:2010	80MHz-1000MHz, 1800MHz,2600MHz, 3500MHz, 5000MHz: 3Vrms (emf), 80%, 1kHz	
EN 55035	EN61000-4-4:2012	012 AC ±1.0kV	
EN 55035	EN 61000-4-5: 2014+A1:2017		
EN 55035	0.15-10MHz:3V 10-30MHz:3-1V 30-80MHz:1V 80%, 1kHz, AM Audio output function: 0.15MHz-30MHz: -20dE		PASS
EN 55035	EN 61000-4-8:2010 50/60 Hz 1A/m		PASS
EN 55035	EN61000-4-11: 2004+A1:2017	0 % $U_T^*$ for 0.5per 0 % $U_T^*$ for 250per 70 % $U_T^*$ for 25per	PASS
	EN 55032 EN 61000-3-2 EN61000-3-3 EN 55035 EN 55035 EN 55035 EN 55035	EN 55032 EN 55032 EN 61000-3-2 EN 61000-3-2 EN61000-3-3 EN61000-3-3 EN 55035 EN61000-4-2:2009  EN 55035 EN61000-4-3: 2006+A1:2007+A2:2010  EN 55035 EN 61000-4-5: 2014+A1:2017  EN 55035 EN61000-4-6: 2014+AC:2015  EN 55035 EN 61000-4-8:2010  EN 55035 EN 61000-4-8:2010	EN 55032 EN 55032 Class B  EN 61000-3-2 EN 61000-3-2 N/A  EN61000-3-3 EN61000-3-3 Clause 5 of EN 61000-3-3  EN 55035 EN61000-4-2:2009 Contact ±4 KV Air ±8 kV  BOMHz-1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz, 3000MHz, 6000MHz, 3000MHz, 6000MHz and output function: 80MHz-1000MHz: 0dB  EN 55035 EN61000-4-4:2012 AC ±1.0kV  EN 55035 EN 61000-4-5: 2014+A1:2017 Line-line:±1kV  EN 55035 EN61000-4-6: 2014+AC:2015 BN 61000-4-6: 2014+AC:2015 BN 61000-4-8:2010  EN 55035 EN 61000-4-8:2010 SN 1kHz, AM Audio output function: 0.15MHz-30MHz: -20dB, 30MHz-80MHz: -10dB  EN 55035 EN 61000-4-8:2010 SN 1kHz, AM Audio output function: 0.15MHz-30MHz: -20dB, 30MHz-80MHz: -10dB  EN 55035 EN 61000-4-8:2010 SN 1kHz AM Audio output function: 0.15MHz-30MHz: -10dB  EN 55035 EN 61000-4-11: 2004+A1:2017 O % U <sub>T</sub> * for 0.5per 0 % U <sub>T</sub> * for 0.5per 0 % U <sub>T</sub> * for 250per

- 1. UT is the nominal supply voltage.
- 2. Pass: Meet the requirements.
- 3. N/A: not applicable.



## 5 General Information

### 5.1 Client Information

Applicant:	Nebra Ltd
Address:	Unit 4 Bells Yew Green Business Court, Bells Yew Green, Tunbridge Wells TN3 9BJ
Manufacturer:	Nebra Ltd
Address:	Unit 4 Bells Yew Green Business Court, Bells Yew Green, Tunbridge Wells TN3 9BJ
Factory:	SUNSOAR TECH CO., LIMITED
Address:	4/F, Block E, Fengze Building, Huafeng No.2 Industrial Park, Hangkong Road, XiXiang Town, BaoAn District, Shenzhen, China

## 5.2 General Description of E.U.T.

Product Name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner			
Model No.:	HNTIN-470-G, HNTIN-868-G, HNTIN-915-G,HNTIN-433-G, HNTIN-470,HNTIN-868, HNTIN-915,HNTIN-433			
Hardware version:	V12-15-2020-1614			
Software version:	a98bfc8			
Power supply:	DC 12V			
AC adapter:	Model: TM-K018VP-01201500PE-Z Input: 100-240V~50/60Hz 0.45A Output: 12.0V , 1.5A			
Remark:	Model No.: HNTIN-470-G, HNTIN-868-G, HNTIN-915-G,HNTIN-433-G, HNTIN-470,HNTIN-868, HNTIN-915,HNTIN-433 has the same internal circuit design, layout, components and internal wiring. The difference is that the ones with the -G suffix have GPS function, while those without the suffix do not. Each model has two appearances, except for the appearance, the interior is exactly the same. In addition, the corresponding frequency of each model of LoRa module is different, as follows:  The Nebra HNT Indoor Notspot is available in 4 variants to support multiple regions.  It is available in the following frequency variants:  433 MHz (HNTIN-433)  470 Mhz (HNTIN-470)  888 Mhz (HNTIN-868)  915 Mhz (HNTIN-915)			

## 5.3 Test mode and voltage and test samples plans

Woking:	Keep the EUT in Woking mode
Test voltage:	AC 230V/50Hz
Remark:	<ol> <li>During the test, pre-scan 120Vac/60Hz and 230Vac/50Hz of the Power supply, found 230Vac/50Hz was worse case mode.</li> <li>The report only reflects the worst mode.</li> </ol>

## 5.4 Description of Support Units

Manufacturer	Description	Model	S/N	FCC ID/DoC
DELL	PC	OPTIPLEX7070	2J8XSZ2	DoC
DELL	MONITOR	SE2018HR	3M7QPY2	DoC
DELL	KEYBOARD	KB216d	N/A	DoC
DELL	MOUSE	MS116t1	N/A	DoC
HP	Printer	HP LaserJet P1007	VNFP409729	DoC



### 5.5 Measurement Uncertainty

Parameter	Expanded Uncertainty (Confidence of 95%)
Conducted Emission (9kHz ~ 30MHz)	±1.60 dB
Radiated Emission (9kHz ~ 30MHz)	±3.12 dB
Radiated Emission (30MHz ~ 1000MHz)	±4.32 dB
Radiated Emission (1GHz ~ 18GHz)	±5.16 dB
Radiated Emission (18GHz ~ 26.5GHz)	±3.20 dB

### 5.6 Description of Cable Used

N/A

### 5.7 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### • FCC- Designation No.: CN1211

Jian Yan Testing Group Shenzhen Co., Ltd. has been accredited as a testing laboratory by FCC(Federal Communications Commission). The test firm Registration No. is 727551.

#### • ISED - CAB identifier.: CN0021

The 3m Semi-anechoic chamber of JianYan Testing Group Shenzhen Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

#### • A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: <a href="https://portal.a2la.org/scopepdf/4346-01.pdf">https://portal.a2la.org/scopepdf/4346-01.pdf</a>

### 5.8 Laboratory Location

Jian Yan Testing Group Shenzhen Co., Ltd.

Address: No.101, Building 8, Innovation Wisdom Port, No.155 Hongtian Road, Huangpu Community, Xinqiao Street, Bao'an District, Shenzhen, Guangdong, People's Republic of China.

Tel: +86-755-23118282, Fax:+86-755-23116366

Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

## 5.9 Monitoring of EUT for the Immunity Test

Visual:	Monitored the display of EUT	
Sound:	Monitored the sound of EUT	
Other:	Monitored the data link of EUT	



### **5.10Test Instruments list**

Radiated Emission:							
Test Equipment	Manufacturer	Model No.	Serial No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)		
3m SAC	ETS	9m*6m*6m	966	01-19-2021	01-18-2024		
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-03-2021	03-02-2022		
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-03-2021	03-02-2022		
EMI Test Software	AUDIX	E3	V	Version: 6.110919b			
Pre-amplifier	HP	8447D	2944A09358	03-03-2021	03-02-2022		
Pre-amplifier	CD	TRLA- 010180G50B	20120401	03-03-2021	03-02-2022		
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-03-2021	03-02-2022		
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-03-2021	03-02-2022		
Simulated Station	Anritsu	MT8820C	6201026545	03-03-2021	03-02-2022		
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-03-2021	03-02-2022		
Cable	MICRO-COAX	MFR64639	K10742-5	03-03-2021	03-02-2022		
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-03-2021	03-02-2022		

Conducted Emission:							
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)		
EMI Test Receiver	Rohde & Schwarz	ESCI 3	101189	03-03-2021	03-02-2022		
RF Switch	TOP PRECISION	RSU0301	N/A	03-03-2021	03-02-2022		
LISN	CHASE	MN2050D	1447	03-03-2021	03-02-2022		
LISN	Rohde & Schwarz	ESH3-Z5	8438621/010	06-18-2020	06-17-2021		
ISN	Schwarzbeck	CAT3 8158	#96	03-03-2021	03-02-2022		
ISN	Schwarzbeck	CAT5 8158	#166	03-03-2021	03-02-2022		
ISN	Schwarzbeck	NTFM 8158	#126	03-03-2021	03-02-2022		
Cable	HP	10503A	N/A	03-03-2021	03-02-2022		
EMI Test Software	AUDIX	E3		/ersion: 6.110919b	)		

ESD:						
Test Equipment	Manufacturer		Model No.	Serial No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)
ESD Simulator	Haefely		ONYX30	183900	03-03-2021	03-02-2022

Conducted Immunity:					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
Conducted Disturbance Test system	SCHLODER	CDG6000	126B1445/2016	03-03-2021	03-02-2022
Coupling/Decoupling Network	SCHLODER	CDN-M2+3	A2210417/2016	03-03-2021	03-02-2022
EM Clamp	SCHLODER	EMCL-20	132A1281/2016	03-03-2021	03-02-2022
Coupling/Decoupling Network	SCHLODER	CDN M5-32A	10204-1	02-02-2021	02-01-2022
Nexus Condutuining Amplifier	B&K	2690-0S2	3003552	N/A	N/A
MUTH Simulator	B&K	4227	N/A	N/A	N/A
Sound Level Calibrator	B&K	4231	N/A	N/A	N/A
Audio Analyzer	Rohde & Schwarz	UPL 16	100150	03-03-2021	03-02-2022



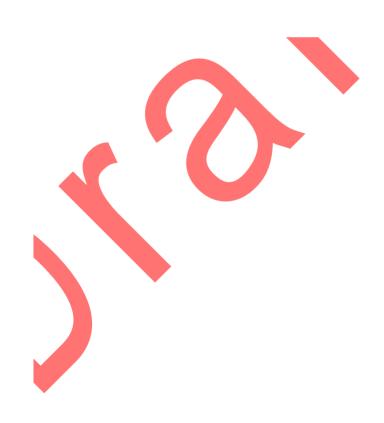
Surge \ EFT \ V-dips \ RW :					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)
Four-in-one Immunity test system	EMC PARTNER	IMU-MGE	109937-1520	01-30-2021	01-29-2022
Lightning test system module	EMC PARTNER	EXT-IMU3000S6 (Surge1.2/50us)	1652	01-30-2021	01-29-2022
Lightning surge high speed communication line coupling network 8 lines (Surge, RW)	EMC PARTNER	CDN-UTP8 ED3	1594	01-30-2021	01-29-2022
Lightning test module of telecommunication terminal	EMC PARTNER	EXT-IMU3000 T6 (Surge 10/700 µ s)	1568	01-30-2021	01-29-2022
Coupling decoupling network of power line (Surge, EFT, RW)	EMC PARTNER	CDN-A-6-32	109037-3063	01-30-2021	01-29-2022
EFT test system module	EMC PARTNER	EXT-IMU3000F5	1626	01-30-2021	01-29-2022
Capacitive coupling clamp EFT	EMC PARTNER	CN-EFT1000/VERI- CP-EFT	1863/1635	01-30-2021	01-29-2022
Voltage dips and Interruption test module	EMC PARTNER	EXT-IMU D	1723	01-30-2021	01-29-2022
Ring wave test module	EMC PARTNER	EXT-IMU3000 R6	1567	01-30-2021	01-29-2022

Radiated Immunity:									
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)				
Signal Generator	Rohde & Schwarz	SMR20	1104.002.20	03-03-2021	03-02-2022				
RF Amplifier 80M-1GHz	Amplifier Research	AR 150W1000	115243	03-03-2021	03-02-2022				
RF Amplifier 1GHz-4.2GHz	Amplifier Research	AR 25S <mark>1G4</mark> AM1	145863	03-03-2021	03-02-2022				
RF Amplifier 4GHz-6GHz	Amplifier Research	35S4G8A	247443	03-03-2021	03-02-2022				
Power Meter	Rohde & Schwarz	NRVS	1020.1809.02	03-03-2021	03-02-2022				
Software EMC32	Rohde & Schwarz	EMC32-S	N/A	N/A	N/A				
Log-periodic Antenna	Amplifier Research	AT1080	3654	03-03-2021	03-02-2022				
Antenna Tripod	Amplifier Research	TP1000A	7412	N/A	N/A				
High Gain Horn Antenna	Amplifier Research	AT4002A	6987	03-03-2021	03-02-2022				
Nexus Condutuining Amplifier	B&K	2690	3003552	N/A	N/A				
MUTH Simulator	B&K	4227	N/A	N/A	N/A				
Sound Level Calibrator	B&K	4231	N/A	N/A	N/A				
Audio Analyzer	Rohde & Schwarz	UPL 16	100150	03-03-2021	03-02-2022				



Harmonic Current/ Voltage Fluctuation and Flicker:									
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)				
Three phase harmonic scintillation analyzer	AMETEK	PACS-3	2046A02916	02-03-2021	02-02-2022				
Three phase harmonic power supply	AMETEK	MX45	2046A00586	02-03-2021	02-02-2022				

PFMF:									
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)				
Power frequency magnetic field generator	Prima	PFM61008TG	PR16088206	11-16-2020	11-15-2021				





## 6 Test Results

## 6.1 EMI (Emission)

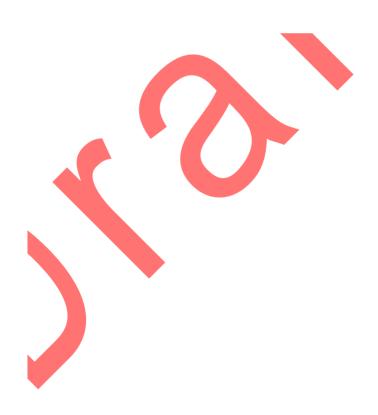
### 6.1.1 Radiated Emission

Test Requirement:	EN55032	EN55032					
Test Method:	EN55032						
Test Frequency Ran	ge: 30MHz to 6GHz						
TestDistance:	3m						
Receiver setup:	Frequency	Detector	R	BW	V	BW	Remark
·	30MHz-1GHz	Quasi-peal	12	0kHz	300	0kHz	QP Value
		Peak		MHz	31	ИНz	PK Value
	Above 1GHz	Average	11	MHz	31	ИНz	AV Value
ITE Limit:	Frequency		imit (dBuV	//m @3m)		F	Remark
	30MHz-230MH	lz	40.	0		Q	P Value
	230MHz-1GH:	z	47.	0		Q	P Value
			50.	0			V Value
	1GHz-3GHz		70.			Р	K Value
			54.				V Value
	3GHz-6GHz		74.				K Value
FM Receiver limit:		I	imit (dBuV				
	Frequency		damental	Harmor	nics	F	Remark
	30MHz-230MH			52		Q	P Value
	230MHz-300MH	Ηz	60	52			P Value
	300MHz-1000M		_	56			P Value
Test setup:	Below 1GHz:			Above	1GHz:		
		The survey of DAT programs of	Retrieve poet of arms to calification	AAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAAA	the second secon		Function  Functi
Test Procedure:	1. The radiated 2. The tabletop ground refere was placed or metallic conta 3. Before final metallic maximum em 4. The frequency radiated emis rotated 360°,	<ol> <li>30MHz to 1GHz:</li> <li>The radiated emissions test was conducted in a semi-anechoic chamber.</li> <li>The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.</li> <li>Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emissions spectrum plots of the EUT.</li> </ol>					





	performed for both horizontal and vertical antenna polarization.  Above 1GHz:
	<ol> <li>The radiated emissions test wasconducted in a fully-anechoic chamber.</li> <li>The tabletop EUT was placed upon anon-metallic table0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.</li> </ol>
	<ol> <li>Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emission spectrum plots of the EUT.</li> </ol>
	4. The frequencies of maximum emission were determined in the final radiated emissions measurement. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were
	performed for both horizontal and vertical antenna polarization.
Test Instruments:	Refer to section 5.10 for details
Test Mode:	Refer to section 5.3 for details
Test Results:	Passed





#### **Measurement Data:**

#### Below 1GHz:

Product Name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product Model: HNTIN-868-G	
Test By:	Yaro	Test mode:	Working mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Vertical
Test Voltage:	AC 230/50Hz	Environment:	Temp: 24°C Huni: 57%

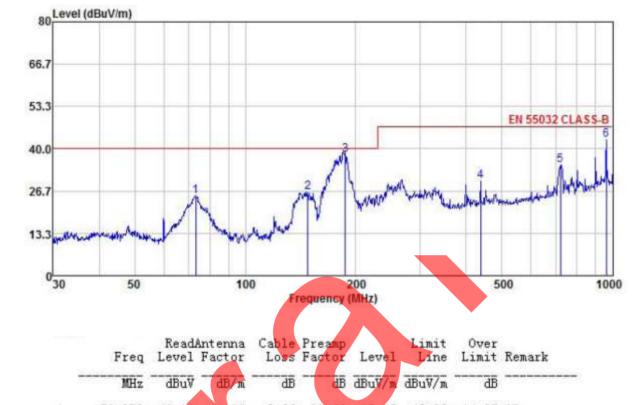


	Freq		Intenna Factor			Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB/m	₫B	dB	dBuV/m	dBu√/m	dB	*******
1	71.832	54.27	10.62	0.66	29.71	35.84	40.00	-4.16	QP
2	187.096	48.85	17.29	1.34	28.92	38.56	40.00	-1.44	QP
3	437.120	44.44	19.18	2.14	28.85	36.91	47.00	-10.09	QP
4	480.528	45.53	19.33	2.31	28.92	38.25	47.00	-8.75	QP
5	842.130	39.50	21.32	3.20	28.03	35.99	47.00	-11.01	QP
4 5 6	962.162	45.34	22.88	3, 53	27.65	44.10	47.00	-2.90	QP

- 1. Final Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor.
- 2. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 3. The Aux Factor is a notch filter switch box loss, this item is not used.



Product Name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product Model:	HNTIN-868-G	
Test By:	Yaro	Test mode:	Working mode	
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Horizontal	
Test Voltage:	AC 230/50Hz	Environment:	Temp: 24°C Huni: 57%	



	MHz	dBu∀	dB/m	₫B	₫B	dBuV/m	dBuV/m	₫₿	
1	73.359	43.10	11.06	0.66	29.69	25.13	40.00	-14.87	QP
2	147.921	40.47	14.14	1.02	29.23	26.40	40.00	-13.60	QP
3	187.096	48.27	17.29			37.98	40.00	-2.02	QP
4	437.120	37.28	19.18	2.14	28.85	29.75	47.00	-17.25	QP
5	721.726	40.04	20.55	2.90	28.58	34.91	47.00	-12.09	QP
6	962.162		22.88	3.53			47.00		
		· · · · · · · · · · · · · · · · · · ·							

- 1. Final Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor.
- 2. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 3. The Aux Factor is a notch filter switch box loss, this item is not used.



#### Above 1GHz:

Product Name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product Model:	HNTIN-868-G	
Test By:	Yaro	Test mode:	Working mode	
Test Frequency:	1 GHz ~ 6 GHz	Polarization:	Vertical	
Test Voltage:	AC 230/50Hz	Environment:	Temp: 24°C Huni: 57%	



- 1. Final Level =Receiver Read level + Antenna Factor + Cable Loss + Aux Factor Preamplifier Factor.
- 2. The emission levels of other frequencies are very lower than the limit and not show in test report.



Product Name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product Model:	HNTIN-868-G
Test By:	Yaro	Test mode:	Working mode
Test Frequency:	1 GHz ~ 6 GHz	Polarization:	Horizontal
Test Voltage:	AC 230/50Hz	Environment:	Temp: 24℃ Huni: 57%



- 1. Final Level =Receiver Read level + Antenna Factor + Cable Loss + Aux Factor Preamplifier Factor.
- 2. The emission levels of other frequencies are very lower than the limit and not show in test report.



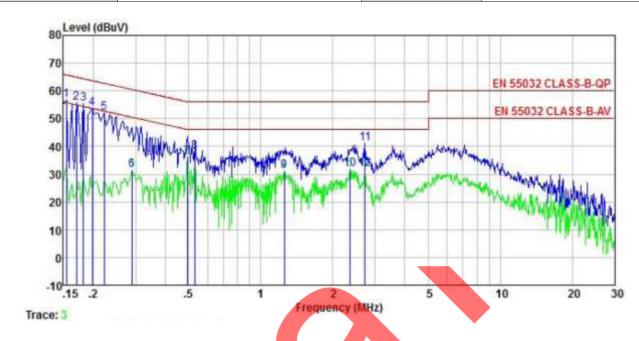
### 6.1.2 Conducted Emission

Test Requirement:	EN 55032		
Test Method:	EN 55032		
TestFrequencyRange:	150kHz to 30MHz		
Class / Severity: Class B	Class B		
Receiver setup:	RBW=9kHz, VBW=30kHz		
Limit:	Fraguency range (MHz)	Limit	(dBuV)
	Frequency range (MHz)	Quasi-peak	Average
	0.15-0.5	66 to 56*	56 to 46*
	0.5-5	56	46
	5-30	60	50
	* Decreases with the logarithm	of the frequency.	
Test setup:	Reference	Plane	
	AUX Equipment  Test table/Insulation plane  Remark: E.U.T: Equipment Under Test LISN Line Impedence Stabilization Net Test table height=0.8m	EMI Receiver	
Test procedure	The E.U.T and simulators are impedance stabilization network coupling impedance for the mare also connected to the mosochm/50uH coupling impedato the block diagram of the tA.C. line are checked for ma find the maximum emission, the interface cables must be conducted measurement.	ork(L.I.S.N.). Which peasuring equipment. I ain power through a name with 50ohm termiest setup and photogoximum conducted inthe relative positions o	rovide a 50ohm/50uH The peripheral devices LISN that provides a ination. (Please refers graphs). Both sides of erference. In order to f equipment and all of
Test Instruments:	Refer to section 5.10 for detail	S	
Test Instruments:	Refer to section 5.3 for details		
Test Mode:	Passed		



#### **Measurement Data:**

Product name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product model:	HNTIN-868-G
Test by:	Yaro	Test mode:	Working mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Line
Test voltage:	AC 230 V/50 Hz	Environment:	Temp: 22.5℃ Huni: 55%



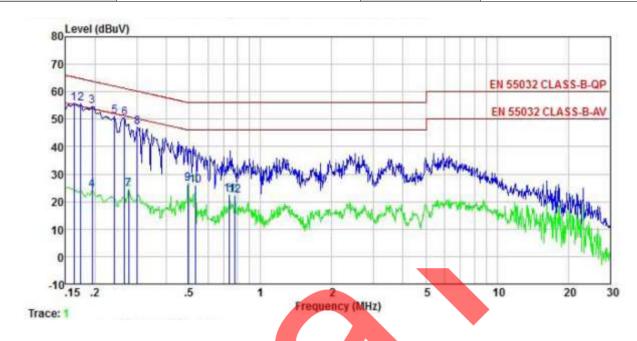
	Freq	Read Level	LISN Factor	Aux Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBu∀	₫B	₫B	dB	dBu∛	₫₿u₹	dB	
1	0.154	46.58	10.20	0.01	0.01	56.80	65.78	-8.98	QP
234567890	0.170	45.39	10.20	0.01	0.01	55.61	64.94	-9.33	QP
3	0.182	45.32	10.20	0.00	0.01	55.53	64.42	-8.89	QP
4	0.198	43, 63	10.20	0.00	0.04	53.87	63.71	-9.84	QP
5	0.222	41.75	10.20	0.00	0.03	51.98	62.74	-10.76	QP
6	0.289	21.22	10.20	0.01	0.03	31.46	50.54	-19.08	Average
7	0.494	25.98	10.20	0.03	0.03	36.24	46.10		Average
8	0.529	27.92	10.20	0.03	0.03	38.18	46.00		Average
9	1.255	20.79	10.22	0.11	0.10	31.22	46.00		Average
0	2.358	21.13	10.27	0.23	0.15	31.78			Average
1	2.721	30, 60	10.30	0.28	0.10	41.28		-14.72	
12	2.721	21.03	10.30	0.28	0.10	31.71			Average

#### Notes

- 1. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 3. Final Level =Receiver Read level + LISN Factor + Cable Loss + Aux Factor.



Product name:	Nebra Smart Indoor LoRa Gateway / Nebra HNT Indoor Hotspot Miner	Product model:	HNTIN-868-G
Test by:	Yaro	Test mode:	Working mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Neutral
Test voltage:	AC 230 V/50 Hz	Environment:	Temp: 22.5℃ Huni: 55%



	Freq	Read Level	LISN Factor	Aux Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	₫B	₫B	dB	dBu₹	dBu∜	dB	
1	0.162	55.86	0.80	0.01	0.01	55.88	65.34	-9.46	QP
1 2 3 4 5 6 7 8 9 10	0.174	55.59	0.00	0.00	0.01	55.60	64.77	-9.17	QP
3	0.194	54.70	0.00	0.00	0.03	54.73	63.84	-9.11	QP
4	0.194	24, 30	0.00	0.00	0.03	24.33	53.84	-29.51	Average
5	0.242	51.05	0.00	0.00	0.01	51.06		-10.98	QP
6	0.266	50.56	0.00	0.01	0.02	50.59	61.25	-10.66	QP
7	0.277	24.66	0.00	0.01	0.02	24.69	50.90	-26.21	Average
8	0.302	47.10	0.00	0.01	0.03	47.14		-13.05	
9	0.494	26.63	0.00	0.03	0.03	26.69	46.10	-19.41	Average
10	0.529	25.89	0.00	0.03	0.03	25.95			Average
11	0.739	22,60	0.00	0.05	0.03	22.68			Average
12	0.779	22, 00	0.00	0.05	0.03	22.08			Average

#### Notes:

- 1. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 3. Final Level =Receiver Read level + LISN Factor + Cable Loss + Aux Factor.

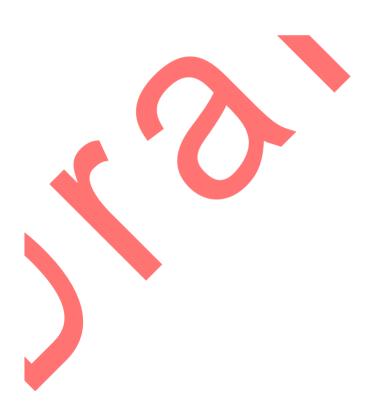


### 6.1.3 Harmonics Test Result

Test Requirement:	EN 61000-3-2
Test Method:	N/A: See Remark Below
Remark	There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2. For further details, please refer to Clause 7, Note 1 of EN 61000-3-2 which states: "For the following categories of equipment limits are not specified in this edition of the standard.  Note 1: Equipment with a rated power of 75W or less, other than lighting equipment."

### 6.1.4 Flicker Test Result

Test Requirement:	EN 61000-3-3
Test Method:	EN 61000-3-3
Remark:	As the section 6.1 of EN 6100-3-3, "Devices and Equipment that do(with the utmost probability) not generate relevant voltage fluctuations or flicker need not to be tested".





## 6.2 EMS (Immunity)

## **6.2.1 Performance Criteria Description in EN 55035**

Criterion A:	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B:	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.  During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.  If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C:	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.  Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.





## 6.2.2 Electrostatic Discharge

possible to touch the EUT. After each discharge, the discharge election was removed from the EUT. The generator was re-triggered for a	Test Requirement:	
Discharge Voltage:  Contact Discharge, HCP and VCP: ±2kV, ±4kV, Air Discharge: ±2kV, ±4kV, ±8kV  Polarity:  Number of Discharge:  Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point.  Discharge Mode:  Single Discharge  Discharge Period:  Testsetup:  Test Procedure:  1) Air discharge:  The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	·	
Air Discharge: ±2kV, ±4kV, ±8kV  Polarity:  Number of Discharge:  Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point.  Discharge Mode:  Discharge Period:  1 second minimum  Testsetup:  Test Procedure:  1) Air discharge:  The test was applied on non-conductive surfaces of EUT. The idischarge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	Test Method:	EN61000-4-2
Polarity: Number of Discharge: Contact Discharge: Minimum 25 times at each test point, Air Discharge Minimum 10 times at each test point.  Discharge Mode: Discharge Period: 1 second minimum  Testsetup:  Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The idischarge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	Discharge Voltage:	
Number of Discharge:  Contact Discharge: Minimum 25 times at each test point, Air Discharge: Minimum 10 times at each test point.  Single Discharge Discharge Period:  Testsetup:  Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a		
Air Discharge: Minimum 10 times at each test point.  Discharge Mode: Single Discharge  Discharge Period: 1 second minimum  Testsetup:  Test Procedure: 1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electwas removed from the EUT. The generator was re-triggered for a		
Discharge Period:  Testsetup:  Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electwas removed from the EUT. The generator was re-triggered for a	Number of Discharge:	· · ·
Discharge Period:  Testsetup:  Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as fa possible to touch the EUT. After each discharge, the discharge electwas removed from the EUT. The generator was re-triggered for a		
Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as far possible to touch the EUT. After each discharge, the discharge electwas removed from the EUT. The generator was re-triggered for a		
Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as far possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	Discharge Period:	1 second minimum
Test Procedure:  1) Air discharge: The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as far possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	Γεσισθίαμ.	Electrostatic Discharge  EUT  470K des  (Chi destatic  Non-Conducted Table
The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as far possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a		Ground Reference Plane
The test was applied on non-conductive surfaces of EUT. The discharge tip of the discharge electrode was approached as far possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a	Tost Procedure:	1) Air discharge:
This procedure was repeated until all the air discharge completed  2) Contact discharge:  The test was applied on conductive surfaces of EUT. The generato re-triggered for a new single discharge and repeated 10 times for pre-selected test point. The tip of the discharge electrode was touc EUT before the discharge switch was operated.  3) Indirect discharge for horizontal coupling plane  At least 10 single discharges shall be applied at the front edge of HCP opposite the centre point of each unit of the EUT and 0.1m fror front of the EUT. The long axis of the discharge electrode shall be in plane of the HCP and perpendicular to its front edge during discharge. Consideration should be given to exposing all sides of EUT.  4) Indirect discharge for vertical coupling plane  At least 10 single discharges were applied to the center of one very edge of the coupling plane. The coupling plane, of dimensions 0.00.5m, was placed parallel to, and positioned at a distance of 0.1m the EUT. Discharges were applied to the coupling plane, with this plane.		discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure was repeated until all the air discharge completed  2) Contact discharge:  The test was applied on conductive surfaces of EUT. The generator was re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. The tip of the discharge electrode was touch the EUT before the discharge switch was operated.  3) Indirect discharge for horizontal coupling plane  At least 10 single discharges shall be applied at the front edge of each HCP opposite the centre point of each unit of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge. Consideration should be given to exposing all sides of the EUT.  4) Indirect discharge for vertical coupling plane  At least 10 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are
	Testenvironment:	
Test Instruments: Refer to section 5.10 for details		•
Test mode: Refer to section 5.3 for details		
Test results: Passed		

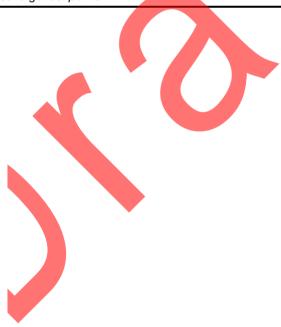


#### **Measurement Record:**

Test mode:	Charging & Recording mode	е		
	I: Please refer to red arrows	s as below plots		
Test points:	II:Please refer to yellow arro	ows as below plots		
Direct discharge				
Discharge Voltage (KV)	Type of discharge	Test points	Observations (Performance Criterion)	Result
± 2, ± 4	Contact	II	А	Pass
± 2, ± 4,± 8	Air	l	Α	Pass

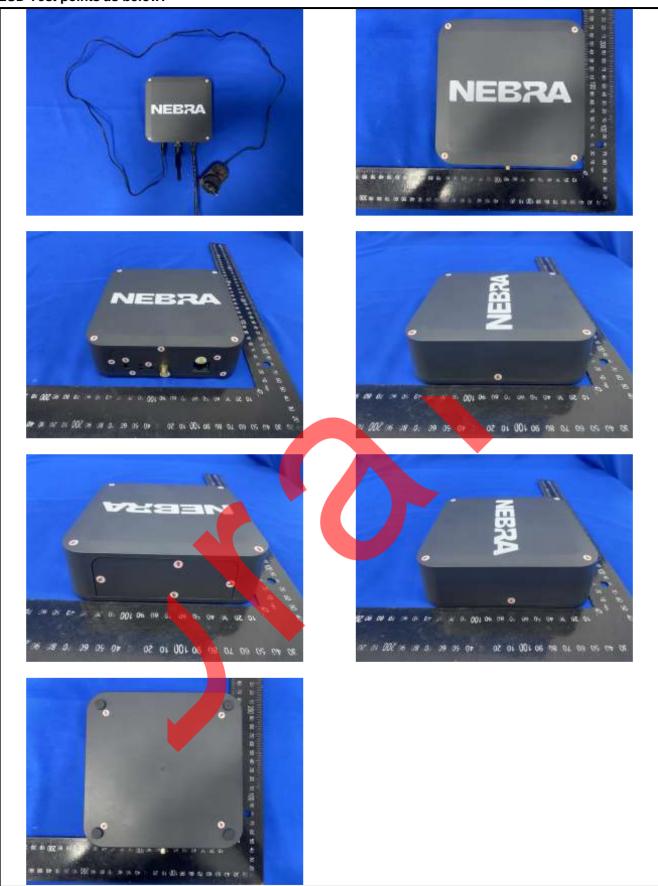
Indirect discharge				
Discharge Voltage (KV)	Type of discharge	Test points	Observation Performance	Result
± 2, ± 4	HCP-Bottom/Top/ Front/Back/Left/Right	Edge of the HCP	А	Pass
± 2, ± 4	VCP-Front/Back /Left/Right	Center of the VCP	А	Pass

- 1. A: No degradation in performance of the EUT was observed.
- 2. Red arrow: Air discharge test points.
- 3. Yellow arrow: Contact discharge test points.





### ESD Test points as below:









## 6.2.3 Continuous RF electromagnetic radiated field disturbances

Test Requirement:	EN 55035
Test Method:	EN61000-4-3
rest Method.	
Frequency range:	Swept test:80MHz to 1GHz Spot test: 1800MHz,2600MHz,3500MHz,5000MHz
Test Level:	3V/m
rest Level.	Audio output function: 80MHz-1000MHz: 0dB
Modulation:	80%, 1kHz Amplitude Modulation
Performance Criterion:	Criteria A
Test setup:	Carounal Reference Place  Opposit  Oppo
Test Procedure:	<ol> <li>For table-top equipment, the EUT was placed in the chamber on a non-conductive table 0.8m high. For arrangement of floor-standing equipment, the EUT was mounted on a non-conductive support 0.1m above the supporting plane. For human body-mounted equipment, the EUT may be tested in the same manner as table top items.</li> <li>If possible, a minimum of 1 m of cable is exposed to the electromagnetic field. Excess length of cables interconnecting units of the EUT shall be bundled low-inductively in the approximate center of the cable to form a bundle 30 cm to 40 cm in length.</li> <li>The EUT was initially placed with one face coincident with the calibration plane. The EUT face being illuminated was contained within the UFA (Uniform Field Area).</li> <li>The frequency ranges to be considered were swept with the signal modulated and pausing to adjust the RF signal level or to switch oscillators and antennas as necessary. Where the frequency range was swept incrementally, the step size was not exceed 1 % of the preceding frequency value.</li> <li>The dwell time of the amplitude modulated carrier at each frequency was not be less than the time necessary for the EUT to be exercised and to respond, and was not less than 5 s.</li> <li>The test normally was performed with the generating antenna facing each side of the EUT.</li> <li>The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.</li> <li>The EUT was performed in a configuration to actual installation conditions, a video camera and/or a audio monitor were used to monitor the performance of the EUT.</li> </ol>
Test environment:	Temp.: 25°C Humid.: 52% Press.: 1012mbar
Test Instruments:	Refer to section 5.10 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed



#### **Measurement Record:**

Test mode: Charging & Recording mode

Continuous RF electromagnetic radiated field disturbances swept test

Frequency	Level	Modulation	Antenna Polarization	EUT Face	Observations (Performance Criterion)	Result
			V	Front	Α	Pass
			Н	Front A  Rear	Α	Pass
			V	D	Α	Pass
80 MHz-1 GHz 3 V/m	4.111	Н	Rear	Α	Pass	
	1 kHz,	V	A A	Pass		
	2.1//	80 % Amp. Mod,	Н	Left A	Pass	
	3 V/M	1 % increment,	V		Pass	
		dwell time=5seconds	Н	Right	A	Pass
		ume=5seconds	V	A	Pass	
			Н	Тор	Α	Pass
			V	V         A           H         A	Α	Pass
			Н		Α	Pass

A: No degradation in the performance of the E.U.T. was observed.

#### Continuous RF electromagnetic radiated field disturbances spot test

Frequency (+/-1%)	Level	Modulation	Antenna Polarization	EUT Face	Observations (Performance Criterion)	Result		
			٧	Front	А	Pass		
			F	Front	A	Pass		
			V	Davis	Α	Pass		
1800MHz, 2600MHz, 3500MHz, 5000MHz	4	Н	Rear	Α	Pass			
	1 kHz, 80 % Amp. Mod,	V		Α	Pass			
								Α
	1 % increment,	V	Disth	Α	Pass			
	dwell time=5seconds	I	Right	Α	Pass			
	unie=55econds	V	Tan	А	Pass			
		Н Тор	тор	А	Pass			
			V	Dattain	А	Pass		
			Н	Bottom	А	Pass		

Remarks:

A: No degradation in the performance of the E.U.T. was observed.



### 6.2.4 Electrical Fast Transients

Test Requirement:	EN 55035			
Test Method:	EN61000-4-4			
Test Level:	1.0kV on AC port			
Polarity:	Positive & Negative			
Repetition Frequency:	5kHz			
Burst Duration:	15ms			
Burst Period:	300ms			
Test Duration:	2 minute per level & polarity			
Performance Criterion:	В			
Test setup:	EMC Tester EUT  Non-conducted table  Ground Reference Plane  Ground Reference Plane			
Test Procedure:	The EUT and its simulators were placed on the ground reference plane			
	and were insulated from it by a wood support 0.1m + 0.01m thick. The ground reference plane was 1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane was project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m. All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables.  Test on Signal Ports, Telecommunication Ports and Control Ports:  The EFT interference signal is through a coupling clamp device couples to the signal and control lines of the EUT with burst noise for 2 minutes.  Test on power supply ports:  The EUT is connected to the power mains through a coupling device that directly couples the EFT/B interference signal.  Each of the Line and Neutral conductors is impressed with burst noise for 2 minutes.  The length of the signal and power lines between the coupling device and the EUT is 0.5m			
Test environment:	Temp.: 25°C Humid.: 63% Press.: 1050mbar			
Test Instruments:	Refer to section 5.10 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Passed			



#### **Measurement Record:**

Test mode: Charging & Recording mode

Lead under Test	Level (±kV)	Coupling Direct/Clamp	Observations (Performance Criterion)	Result
L	± 1.0	Direct	Α	Pass
N	± 1.0	Direct	Α	Pass
L-N	± 1.0	Direct	А	Pass
LAN	± 0.5	Direct	Α	Pass

Remark:

A: No degradation in the performance of the E.U.T. was observed.





## 6.2.5 Surge

Test Requirement:	EN 55035			
Test Method:	EN61000-4-5			
Test Level:	$\pm$ 1 kV Live to Neutral: Differential mode $\pm$ 2 kV Live to Earth or Neutral to Earth: Common mode			
Polarity:	Positive & Negative			
Generator source impedance:	2Ω (line-line coupling)			
Test Interval:	60s between each surge			
No. of surges:	5 positive, 5 negative at 0°, 90°, 180°, 270°.			
Performance Criterion:	В			
Test setup:	BOCM Non-conducted table Ground Reference Plane  Ground Reference Plane			
Test Procedure:	<ol> <li>For line-to-line coupling mode, provide a 1kV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points, and for active line / neutral lines to ground are same except test level is 2kV.</li> <li>At least 5 positive and 5 negative (polarity) tests with a maximum 1/minrepetition rate are applied during test.</li> <li>Different phase angles are done individually.</li> <li>Record the EUT operating situation during compliance test and decide the EUTimmunity criterion for above each test.</li> </ol>			
Test environment:	Temp.: 26°C Humid.: 53% Press.: 1012mbar			
Test Instruments:	Refer to section 5.10 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Passed			



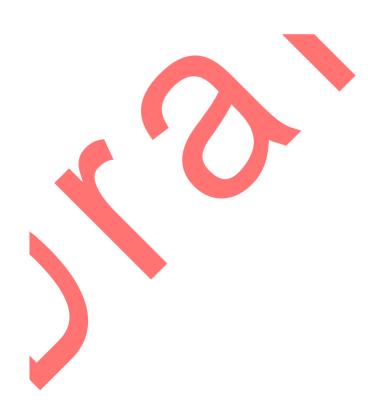
#### **Measurement Record:**

Test mode: Charging & Recording mode

Location	Level(kV)	Pulse No	Surge Interval	Phase(deg)	Observations (Performance Criterion)	Result			
	L-N ± 1	L-N ± 1 5				00-	0°	А	Pass
LN			_	_	00		90°	Α	Pass
L-IN			Ι Ι	ΙΙ	5	180°	60s	005	А
				270°	А	Pass			
LAN	± 0.5	5	60S	/	А	Pass			

Remark:

A: During the test, The EUT works normal, and after the test, the function of the EUT is normal.





### 6.2.6 Continuous induced RF disturbances

Test Requirement:	EN 55035				
Test Method:	EN61000-4-6				
Frequency range:	0.15MHz to 80MHz				
Test Level:	0.15-10MHz:3V 10-30MHz:3-1V 30-80MHz:1V Audio output function: 0.15MHz-30MHz: -20dB, 30MHz-80MHz: -10dB				
Modulation:	80%, 1kHz Amplitude Modulation				
Performance Criterion:	Criteria A				
Test setup:	Shielding Room  Signal Generator Power Amplifier Fixed Pad Non-conducted Table CND EUT Insulating Support 10cm  Ground Reference Plane Ground Reference Plane				
Test Procedure:	<ol> <li>Let the EUT work in test mode and test it.</li> <li>The EUT are placed on an insulating support 0.1m high above a groundreference plane. CDN (coupling and decoupling device) is placed on theground plane about 0.3m from EUT. Cables between CDN and EUT are asshort as possible, and their height above the ground reference plane shall bebetween 30 and 50 mm (where possible).</li> <li>The disturbance signal described below is injected to EUT through CDN.</li> <li>The EUT operates within its operational mode(s) under intended climaticconditions after power on.</li> <li>The frequency range is swept from 0.150MHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1 kHz sinewave.</li> <li>The rate of sweep shall not exceed 1.5*10-3decades/s. Where the frequency isswept incrementally; the step size shall not exceed 1% of the start andthereafter 1% of the preceding frequency value.</li> <li>Recording the EUT operating situation during compliance testing and decidethe EUT immunity criterion.</li> </ol>				
Test environment:	Temp.: 24°C Humid.: 51% Press.: 1012mbar				
Test Instruments:	Refer to section 5.10 for details				
Test mode:	Refer to section 5.3 for details				
Test results:	Passed				



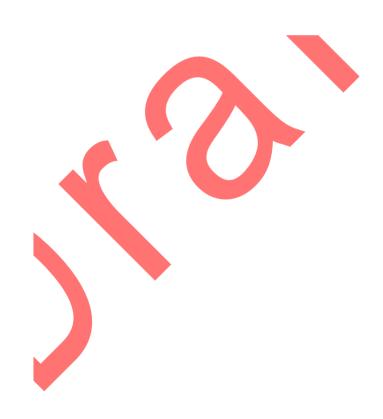
#### **Measurement Record:**

Test mode: Charging & Recording mode

Frequency	Injected Position	Test Level	Modulation	Step Size	Dwell Time	Observations (Performance Criterion)	Result	
150kHz to 10MHz		3V 3V to1V	3V				Α	Pass
10MHz to 30MHz	AC Main		80%, 1kHz — Amp. Mod.	1%	2s	Α	Pass	
30MHz to 80MHz		1V				Α	Pass	
150kHz to 10MHz		3V				Α	Pass	
10MHz to 30MHz	LAN	3V to1V	80%, 1kHz Amp. Mod.	1%	2s	А	Pass	
30MHz to 80MHz		1V	, anp. Mou.			A	Pass	

Remark:

A: No loss of function was observed.





## 6.2.7 Power frequency magnetic field

Test Requirement:	EN 55035		
Test Method:	EN61000-4-8		
Test Frequency:	50/60 Hz		
Test Level:	1 A/m		
Performance Criterion:	Criteria A		
Test setup:	Twisted cable length maximum 2 m		
Test Procedure:	The EUT place center of the test magnetic field coils.  The plane of the inductive coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.  The signal generator generates a magnetic field of 1A/m for testing.		
Test environment:	Temp.: 24°C Humid.: 51% Press.: 1012mbar		
Test Instruments:	Refer to section 5.10 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed		

#### **Measurement Record:**

Test mode: Charging & Recording mode

Test Frequency (Hz)	Test Level (A/m)	Observations (Performance Criterion)	Result
50	1	A	Pass
60	1	A	Pass
Remark: A: No loss of function was observed.			



## 6.2.8 Voltage Dips and Voltage Interruptions

Test Requirement:	EN 55035			
Test Method:	EN61000-4-11			
Test Level:	0% of VT(Supply Voltage) for 0.5 period 70% of VT(Supply Voltage) for 25 period 0% of VT(Supply Voltage) for 250 period			
No. of Dips / Interruptions:	3 per Level			
Performance Criterion:	>95% VD, 0.5 periodPerformance criterion: B 30% VD, 25 periodPerformance criterion: C >95% VI, 250 periodPerformance criterion: C			
Test setup:	BOcm Non-conducted table Ground Reference Plane			
	Ground Reference Plane			
Test Procedure:	<ol> <li>The EUT and test generator were setup as shown on above setup photo.</li> <li>The interruptions are introduced at selected phase angles with specified duration.</li> <li>Record any degradation of performance.</li> </ol>			
Test environment:	Temp.: 25°C Humid.: 63% Press.: 1050mbar			
Test Instruments:	Refer to section 5.10 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Passed			

#### **Measurement Record:**

Test mode: Charging & Recording mode

Test Level % U <sub>T</sub>	Duration (Periods)	Phase angle	No of dropout	Time between dropout	Observations (Performance Criterion)	Result
0	0.5	0°, 90°, 180°, 270°	3	10ms	А	Pass
70	25	0°, 90°, 180°, 270°	3	500ms	А	Pass
0	250	0°, 90°, 180°, 270°	3	5000ms	В	Pass

#### Remark:

A: No loss of function was observed.

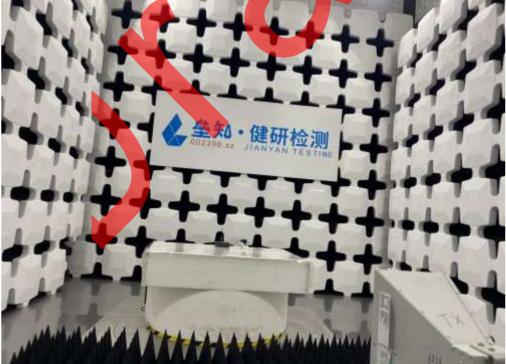
B:After the test, the equipment can operate as intended without operator intervention. No loss of function was observed.



## **Test Setup Photo**

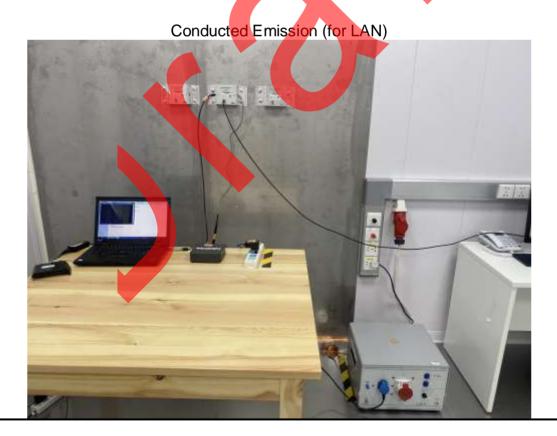












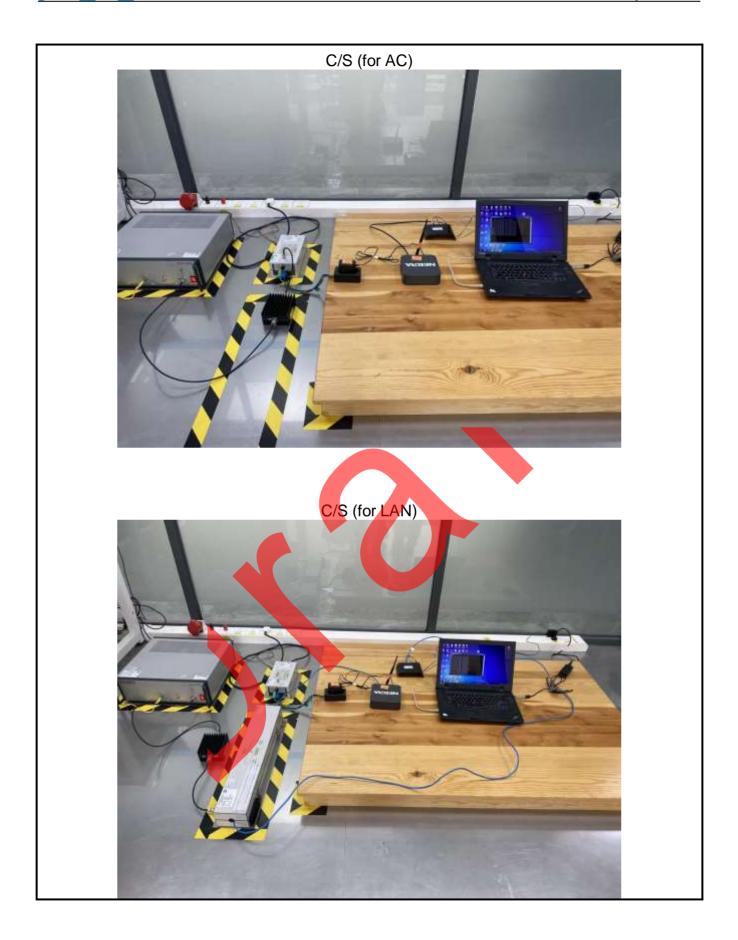


















## 8 EUT Constructional Details

Reference to the test report No..

-----End of report-----

